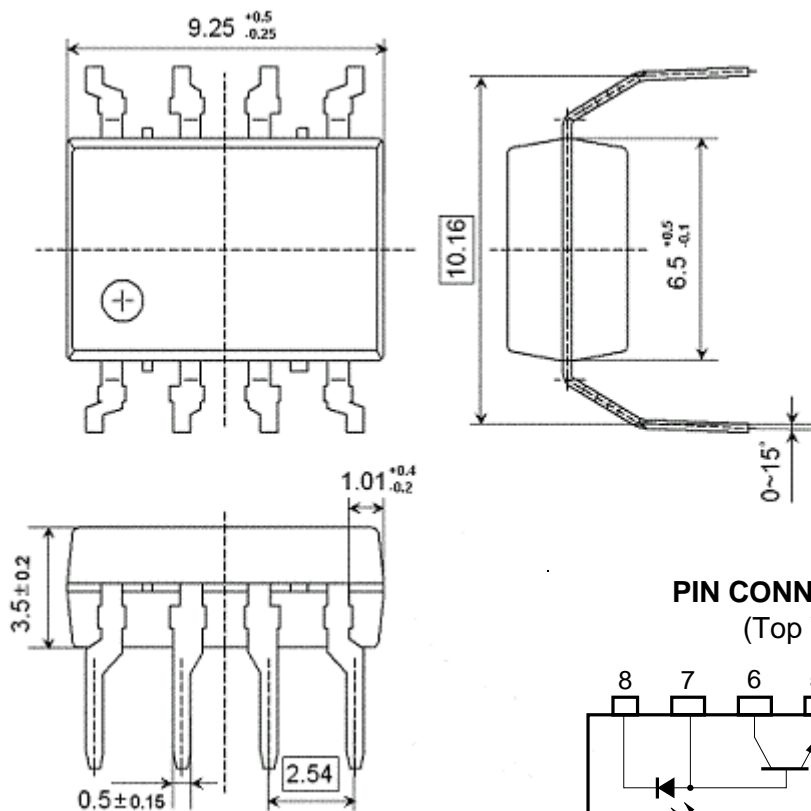


High Speed Analog Output Type 8 mm Creepage 8-Pin Photocoupler PS8501L1

■ Features

- High supply voltage ($V_{CC} = 35\text{ V MAX.}$)
- High speed response ($t_{PHL}, t_{PLH} = 0.8\ \mu\text{s MAX.}$)
- High isolation voltage ($B_v = 5\ 000\text{ Vr.m.s.}$)
- TTL, CMOS compatible with a resistor

■ Package Dimensions (In millimeters)



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■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter		Symbol	Ratings	Unit
Diode	Forward Current ^{*1}	I_F	25	mA
	Reverse Voltage	V_R	5	V
Detector	Supply Voltage	V_{CC}	35	V
	Output Voltage	V_O	35	V
	Output Current	I_O	8	mA
	Power Dissipation ^{*2}	P_C	100	mW
Isolation Voltage ^{*3}		BV	5000	Vr.m.s.
Operating Ambient Temperature		T_A	-55 to +100	$^\circ\text{C}$
Storage Temperature		T_{stg}	-55 to +125	$^\circ\text{C}$

*1 Reduced to 0.33 mA/ $^\circ\text{C}$ at $T_A = 70^\circ\text{C}$ or more.

*2 Reduced to 2.0 mA/ $^\circ\text{C}$ at $T_A = 75^\circ\text{C}$ or more.

*3 AC voltage for 1 minute at $T_A = 25^\circ\text{C}$, RH = 60% between input and output.
Pins 1-4 shorted together, 5-8 shorted together.

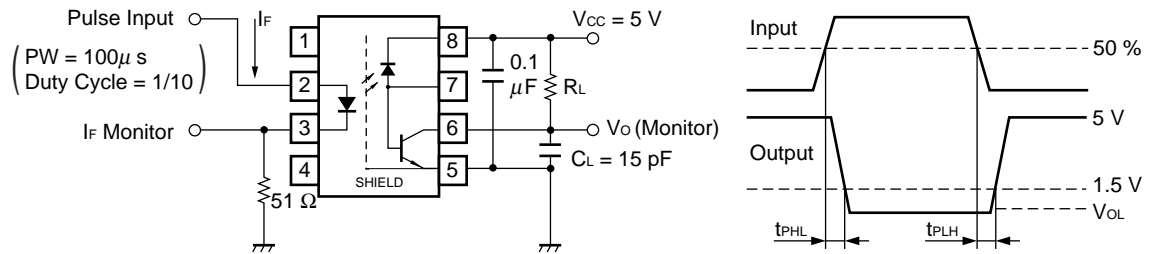
■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter		Symbol	Conditions	MIN.	TYP. ^{*1}	MAX.	Unit
Diode	Forward Voltage	V_F	$I_F = 16\text{ mA}$		1.7	2.2	V
	Reverse Current	I_R	$V_R = 3\text{ V}$			10	μA
	Forward Voltage Temperature Coefficient	$\Delta V_F / \Delta T$	$I_F = 16\text{ mA}$		-2.1		mV/ $^\circ\text{C}$
	Terminal Capacitance	C_t	$V = 0\text{ V}$, $f = 1\text{ MHz}$		60		pF
Detector	High Level Output Current I	$I_{OH(1)}$	$I_F = 0\text{ mA}$, $V_{CC} = V_O = 5.5\text{ V}$		3	500	nA
	High Level Output Current	$I_{OH(2)}$	$I_F = 0\text{ mA}$, $V_{CC} = V_O = 35\text{ V}$			100	μA
	Low Level Output Voltage	V_{OL}	$I_F = 16\text{ mA}$, $V_{CC} = 4.5\text{ V}$, $I_O = 2.4\text{ mA}$		0.15	0.4	V
	Low Level Supply Current	I_{CCL}	$I_F = 16\text{ mA}$, $V_O = \text{Open}$, $V_{CC} = 35\text{ V}$		150		μA
	High Level Supply Current	I_{CCH}	$I_F = 0\text{ mA}$, $V_O = \text{Open}$, $V_{CC} = 35\text{ V}$		0.01	1	μA
	DC Current Gain	h_{FE}	$V_O = 5\text{ V}$, $I_O = 3\text{ mA}$			65	
Coupled	Current Transfer Ratio CTR		$I_F = 16\text{ mA}$, $V_{CC} = 4.5\text{ V}$, $V_O = 0.4\text{ V}$	15			%
	Isolation Resistance	R_{I-O}	$V_{I-O} = 1\text{ kV}_{DC}$	10^{11}			Ω
	Isolation Capacitance	C_{I-O}	$V = 0\text{ V}$, $f = 1\text{ MHz}$		0.7		pF
	Propagation Delay Time (H \rightarrow L) ^{*2}	t_{PHL}	$I_F = 16\text{ mA}$, $V_{CC} = 5\text{ V}$, $R_L = 1.9\text{ k}\Omega$		0.22	0.8	μs
	Propagation Delay Time (L \rightarrow H) ^{*2}	t_{PLH}	$I_F = 16\text{ mA}$, $V_{CC} = 5\text{ V}$, $R_L = 1.9\text{ k}\Omega$		0.35	0.8	μs

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*1 Typical values at $T_A = 25\text{ }^\circ\text{C}$

*2 Test circuit for propagation delay time



C_L includes probe and stray wiring capacitance